- <b>1</b>   [			STANE ating Tem		TÜV, and UL certifcation pl		Stor	age T4	emperati	ire			
	F	Oper	rating Temperature Range		-25°C to +105°C		5.01	Storage Ten Ranç			-10°C to +60°C		
Ra	ating	Voltage Current		Э	AC 1000V , DC 15						2		
				t	175A (60mm² cab 240A (100mm² cal	60mm² cable)         Applicable Cable         60mm²(AW           00mm² cable)         Applicable Cable         100mm² (AW				60mm²(AWG1/0 100mm² (AWG4/0	) ))		
					SPEC	CIFICA	TIONS	S					
		ЕМ			TEST METHOD				F	REQU	JIREMENTS	QT	Α
CO	NSTR	UCT											
General Examination				Examined visually and with a measuring instrument.				Accord	ling to th	e drav	wina.	Х	)
Mark				Confirmed					ing to th	e ala	·····9·	Х	2
			-	ACTER								<b>r</b>	T
Contact Resistance				Measured at DC 1A.			0.1mΩ MAX.				Х	-	
Insulation Resistance			nce	Measured at DC 500V.			1000MΩ MIN.				Х	-	
Voltage Proof				AC 5000V applied for 1min. (JIS C 8201)				No flashover or breakdown.				х	-
Short-Time Withstand Current Test				Measured at 7200A applied for 1s. (60mm <sup>2</sup> cable) Measured at 12000A applied for 1s. (100mm <sup>2</sup> cable) (JIS C 8201)			Contact Resistance: 0.15 m $\Omega$ MAX.				x	-	
ME	CHAN	IICA	L CHAF	RACTER	RISTICS								
Crimp Contact Insertion and Extraction Forces				Measured with an applicable connector.				Insertion Force: 280N MAX. Extraction Force: 250N MAX.				х	-
Mechanical Operation				Contact Inserted and Extracted 50 times.				<ol> <li>No function impairing damage, cracks, or looseness of parts.</li> <li>Contact Resistance: 0.15mΩ MAX.</li> <li>Insertion Force: 280N MAX.</li> <li>Extraction Force: 250N MAX.</li> </ol>				х	-
Vibration 1				Frequency: 10 Hz to 55 Hz Single amplitude: 0.75 mm Performed two hours in each of three mutually perpendicular directions. (MIL-STD-1344 Method 2005, Condition 2)				<ol> <li>No electrical disconuity of 10µs.</li> <li>No damage, cracks, or looseness of parts.</li> </ol>				x	-
Shock				Acceleration: 500 m/s <sup>2</sup> Half sine wave pulses of 11 ms. Performed five times both ways in each of three mutually perpendicular directions.			<ol> <li>No electrical disconuity of 10µs.</li> <li>No damage, cracks, or looseness of parts.</li> </ol>				x	-	
Contact Retention Force				250 N (60mm <sup>2</sup> cable) 351 N (100mm <sup>2</sup> cable) A pulling force was applied to the connection side. (NECA C 2811)			No damage.				x	-	
EN	VIRON	IME	NTAL C	HARAC	CTERISTICS								
Damp Heat (Steady State)				so nours. Returned to room temperature and normal				<ol> <li>Insulation Resistance: 20MΩ MIN.</li> <li>Voltage Proof: AC 5000V applied for 1min. No flashover or breakdown.</li> <li>No damage, cracks, or looseness of parts.</li> </ol>				x	-
Heat and Cold Resistance				temperatu	ubiastad to 25,2°C for 2 hours. Baturned to room				<ol> <li>Insulation Resistance: 20MΩ MIN.</li> <li>Voltage Proof: AC 5000V applied for 1min. No flashover or breakdown.</li> <li>No damage, cracks, or looseness of parts.</li> </ol>				
Ageing Test				240A (100 With the r subjected Subjected	A (60mm <sup>2</sup> cable) A (100mm <sup>2</sup> cable) the rated current shown above applied,				<ol> <li>Contact Resistance: 0.15mΩ MAX.</li> <li>No damage, cracks, or looseness of parts.</li> </ol>				-
	COUN	Т	DE	SCRIPTIC	ON OF REVISIONS		DESIG	NED			CHECKED	DA	ΥE
$\wedge$	1			DIS-C-00003876 EK. K			I DO			TP. KOMATSU	2020	0031	
Note	<b>es</b> (1)			cations sh imp contac		e values in assembled condition with			APPROVED			2019052	
(2) Including temperature rise caused by current carrying.						ina.			CHECKED		TP. KOMATSU	2019052	
			•				DESIGNED		NED	EK. KIDO	201905		
Jnle	ss othei	wise	specified,	refer to IEC 60512 (JIS C 5402).				DRAWN EK. K		EK. KIDO	20190521		
Vote	QT:Q	ualific	ation Tes	at AT:Assurance Test X:Applicable Test			DRAWIN						)
			SF	PECIFICATION SHEET			PART NO.		EF2A-DH200B-1				
			HIR	ROSE ELECTRIC CO., LTD.			CODE NO.		CL142-0229-0-00			Δ	1/